

STB8810B LCR Meter

Features

- 100Hz,120Hz,1kHz,10kHz 4 typical test frequencies
- 4.3 inch TFT liquid crystal display, Chinese and English optional operation interface
- 6-digit reading resolution
- Maximum test speed:12.5ms, support low frequency and high speed:TX4+3ms
- 10 bins sorting, test sorting is more perfect
- 100 sets of LCRZ instrument setting files, 10 measurements
- Soft power switch
- Support 110V/220V two power supply voltages
- 10-point list sweep, support multi-frequency test sorting
- Ultra-low signal source output offset (<100µV), meeting the needs of large inductor, common mode choke inductor test
- Super impact protection
- Power on state lock button;
- Empty fixture judgment
- Data logging function
- Screen capture function
- Interface function, timing, trigger delay, etc. are more complete





standard standard

STB8810B

Support SCPI, MODBUS protocol Rack mount (mm: 215(Wx 88(Hx 335(D Dimension (mm 235(Wx 105(Hx360(D Weight: 3.6kg

Applications

■ Passive components:

Evaluation of Impedance Parameters for Capacitors, Inductors, Cores, Resistors, piezoelectric devices, Transformers, Chip Components, and Network Components

Other components: Impedance evaluation of printed circuit boards, relays, switches, cables, batteries, etc.

Specifications

| Model | STB8810B |
|-----------------------------------|--|
| Basic accuracy | 0.1% |
| Test frequency | 100Hz,120Hz,1kHz,10kHz |
| Test parameters | L, C, R, $ Z $, D, Q, X, θ d, θ r, Vm, Im, \triangle % |
| V/I monitor | Yes |
| AC test signal level | 0.1Vrms,0.3Vrms,1Vrms |
| Signal source internal resistance | 10Ω, 100Ω |
| Test terminal configuration | 5-terminal |
| Test speed (ms/time) | Fast: 19ms; Medium:83ms; Slow: 333ms F≤120Hz Fast :4XT+3ms |
| Zero clearing | Open, Short, Load |
| List sweep | ·10-point list sweep ·Each scan point can be individually sorted, support multi-frequency combined test sorting ·Scanning test for frequency and AC voltage |
| Equivalent Circuit | Series, Parallel |
| Range mode | AUTO, HOLD |
| Trigger mode | Internal, External, Manual, Bus |
| Average times | 1-255 |
| Arithmetical operation | Direct reading, $\triangle ABS$, $\triangle \%$ |
| Delay | Trigger delay, step delay: 0—60.000s, 1ms step |
| General function | Series, parallel equivalent mode, calibration: open circuit, short circuit, range selection: automatic, manual, trigger mode: INT, MAN, EXT, BUS, keyboard lock function |
| Comparator | 10 bins sorting,BIN1-BIN9,NG,AUX; Bin count function PASS, FALL front panel LED display |
| Nonvolatile storage | 100 sets of LCRZ instrument setting files, 10 test results |
| External USB storage | Instrument setting file, CSV data file |

Standard Accessories

Three core power cord

SBF0048A 4-terminal test fixture SBF0011CS 4-terminal Kelvin test cable SBF0010 Gilded shorting plate